



1200 V 65 mΩ SiC MOSFET

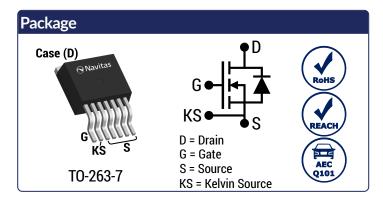
Silicon Carbide MOSFET

Trench-Assisted Planar Technology

 $\begin{array}{llll} V_{DS} & = & 1200 \text{ V} \\ R_{DS(ON)}(Typ.) = & 65 \text{ m}\Omega \\ I_{D}(T_{C} = 100^{\circ}\text{C}) & = & 25 \text{ A} \\ \end{array}$

Features

- Gen3F (3rd Generation) Technology
- Most Stable R_{DS(ON)} over Temperature
- Low Coss, Crss and Balanced Ciss/Crss
- Lower Q_{GD} and Balanced R_{G(INT)}
- Electromagnetically Optimized Design
- Robust Body Diode with Low V_F and Low Q_{RR}
- 100% Avalanche (UIL) Tested
- AEC-Q101 Qualified



Advantages

- Superior Performance and Robustness
- Lowest Conduction Losses at all Temperatures
- Lesser Switching Spikes and Lower Losses
- Faster and More Efficient Switching
- Reduced Ringing
- Ease of Paralleling without Thermal Runaway
- Excellent Power Density and System Efficiency
- Enhanced System Reliability

Applications

- xEV OBC & DC-DC
- EV Fast Charging Infrastructure
- Solar / PV
- Energy Storage Systems
- Uninterruptible Power Supply
- Motor Control
- Induction Heating & Welding
- High Voltage Converters

Absolute Maximum Ratings (At T _C = 25°C Unless Otherwise Stated)						
Parameter	Symbol	Conditions	Values	Unit	Note	
Drain-Source Voltage	$V_{\text{DS(max)}}$	V_{GS} = 0 V, I_D = 100 μA	1200	V		
Gate-Source Voltage (Dynamic)	$V_{\text{GS(max)}}$		-10 / +22	V		
Gate-Source Voltage (Static)	$V_{GS(op)-ON}$	Recommended Operation	18	V	Note 1	
Gate-Source voltage (Static)	$V_{GS(op) ext{-}OFF}$	neconinented operation	-5 to -3	V	Note i	
		$T_C = 25^{\circ}C$, $V_{GS} = -5 / +18 V$	36			
Continuous Drain Current	I_{D}	$T_C = 100$ °C, $V_{GS} = -5 / +18 V$	25	Α	Fig. 16	
		$T_C = 135^{\circ}C$, $V_{GS} = -5 / +18 V$	18			
Pulsed Drain Current	I _{D(pulse)}	$t_P \le 3\mu s$, $D \le 1\%$, $V_{GS} = 18~V$	70	Α	Note 2	
Power Dissipation	P_D	$T_c = 25^{\circ}C$	156	W	Fig. 17	
Non-Repetitive Avalanche Energy	E _{AS}	$L = 8 \text{ mH}, I_{AV} = 6.5 \text{ A}$	169	mJ		
Operating Junction and Storage Temperature	T_{j} , T_{stg}		-55 to 175	°C		

Note 1: This product can support 0V turn-off gate drive voltage with optimized PCB layout and gate drive circuit configuration.

Note 2: Pulse Width tp Limited by T_{j(max)}



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Electrical Characteristics (At T _C = 25°C Unless Otherwise Stated)							
Parameter	Symbol	Conditions	Values			Unit	Note
	Syllibol	Conditions	Min.	Тур.	Max.	Ullit	Note
Drain-Source Breakdown Voltage	V _{DSS}	$V_{GS} = 0 \text{ V, } I_D = 100 \mu\text{A}$	1200			V	
Zero Gate Voltage Drain Current	I _{DSS}	V_{DS} = 1200 V, V_{GS} = 0 V		1	50	μΑ	
Gate Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V, } V_{GS} = 22 \text{ V}$			100	nA	
		V_{DS} = 0 V, V_{GS} = -10 V			-100		
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 10 \text{ mA}$	2.2	3.1	4.3	V	Note 3
Transconductance	g fs	$V_{DS} = 10 \text{ V, } I_D = 13 \text{ A}$		7.1		S	Fig. 5
Transconductance	yıs	$V_{DS} = 10 \text{ V, } I_D = 13 \text{ A, } T_j = 175 ^{\circ}\text{C}$		8.1			1 lg. 5
Drain-Source On-State Resistance	R _{DS(ON)}	$V_{GS} = 18 \text{ V, } I_D = 13 \text{ A}$		65	86	mΩ	Fig. 6-9
	1 (DS(ON)	$V_{GS} = 18 \text{ V, } I_D = 13 \text{ A, } T_j = 175 ^{\circ}\text{C}$		122		11122	
Input Capacitance	Ciss			1298			
Output Capacitance	Coss	_		53		pF	Fig. 12
Reverse Transfer Capacitance	C _{rss}	_		4.5			
Coss Stored Energy	E _{oss}	$ V_{DS} = 800 \text{ V, } V_{GS} = 0 \text{ V}$ $-$		20		μJ	Fig. 13
Coss Stored Charge	Qoss	_ f = 500 KHz, V _{AC} = 25mV		70		nC	
Effective Output Capacitance (Energy Related)	$C_{o(er)}$, ,,,		62		_	
Effective Output Capacitance (Time Related)	C _{o(tr)}	-		88		pF	Note 4
Gate-Source Charge	Q _{gs}	$V_{DS} = 800 \text{ V}, V_{GS} = -5 / +18 \text{ V}$		15			
Gate-Drain Charge	Q _{gd}	I _D = 13 A		16		nC	Fig. 11
Total Gate Charge	Qg	Per JEDEC JEP-192		55			
Internal Gate Resistance	R _{G(int)}	V _{GS} = 18 V, f = 1 MHz, V _{AC} = 25 mV		1.3		Ω	
Turn-On Switching Energy (Body Diode)	E _{On}	$T_i = 25$ °C, $V_{GS} = -5/+18$ V, $R_{G(ext)} = 8 \Omega$, L =		1	F: 04 07		
Turn-Off Switching Energy (Body Diode)	E _{Off}	80.0 μH, I _D = 20 A, V _{DD} = 600 V		25		μJ	Fig. 24-27
Turn-On Delay Time	t _{d(on)}			24			Fig. 26
Rise Time	t _r	$V_{DD} = 800 \text{ V}, V_{GS} = -5/+18 \text{ V}$		15			
Turn-Off Delay Time	t _{d(off)}	$R_{G(ext)} = 8 \Omega$, L = 80.0 μH, $I_D = 20 A$ Timing relative to V_{DS} , Inductive load		17		ns	
Fall Time	t _f	- Tilling relative to VDS, inductive load		10			

Note 3: Tested after applying 30ms pulse at Vgs= +25V

Note 4: $C_{o(er)}$, a lumped capacitance that gives same stored energy as C_{OSS} while V_{DS} is rising from 0 to 800V. $C_{o(tr)}$, a lumped capacitance that gives same charging times as C_{OSS} while V_{DS} is rising from 0 to 800V.

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Reverse Diode Characteristics							
Parameter	Symbol	Conditions		Values			Note
	Syllibol	Conditions	Min.	Тур.	Max.	Unit	Note
Diode Forward Voltage	V_{SD}	V_{GS} = -5 V, I_{SD} = 6 A		4.1		٧	Fig. 18-19
	VSD	V_{GS} = -5 V, I_{SD} = 6 A, T_j = 175°C		3.6		V	Fig. 10-19
Continuous Diode Forward Current	Is	$V_{GS} = -5 \text{ V, } T_c = 100^{\circ}\text{C}$			16	٨	
		$V_{GS} = -5 \text{ V, } T_c = 25^{\circ}\text{C}$		26	Α		
Diode Pulse Current	I _{S(pulse)}	V _{GS} = -5 V		64		Α	Note 2
Reverse Recovery Time	t _{rr}	V 5VI 10 A V 000 V		15		ns	
Reverse Recovery Charge	Qrr	$V_{GS} = -5 \text{ V, } I_{SD} = 13 \text{ A, } V_R = 800 \text{ V}$ $dif/dt = 1000 \text{ A/}\mu\text{s, } T_i = 25^{\circ}\text{C}$		64		nC	
Peak Reverse Recovery Current	Irrm	uii/ut - 1000 A/μs, 1 _J - 25 C		4.6		Α	
Reverse Recovery Time	t _{rr}	V 5VI 10.1 V 2001		23		ns	
Reverse Recovery Charge	Q _{rr}	$V_{GS} = -5 \text{ V, } I_{SD} = 13 \text{ A, } V_{R} = 800 \text{ V}$ $dif/dt = 1000 \text{ A/}\mu\text{s, } T_{i} = 175^{\circ}\text{C}$		160		nC	
Peak Reverse Recovery Current	I _{rrm}	uii/ut - 1000 A/μs, 1 _J - 175 C		7		Α	

Package Characteristics					
Parameter	Symbol	Conditions	Values	Unit	Note
Max Thermal Resistance, Junction - Case	R _{thJC-Max}	Maximum	0.93	°C/W	Fig. 14
Weight	\mathbf{W}_{T}		1.45	g	
Moisture Sensitivity Level	MSL		1		
EMC Material Group			II		

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Fig 1: Typical Output Characteristics ($T_j = 25$ °C)

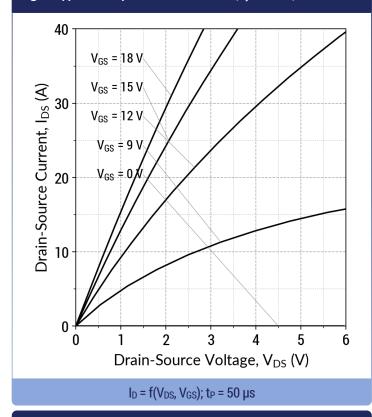
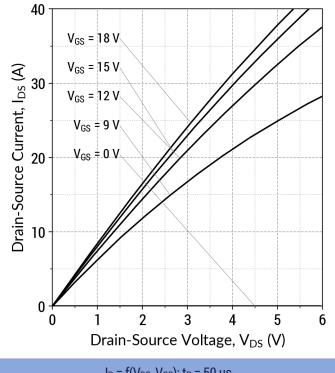


Fig 2: Typical Output Characteristics ($T_j = 175$ °C)



 $I_D = f(V_{DS}, V_{GS}); t_P = 50 \mu s$

Fig 3: Typical Output Characteristics (T_j = -55°C)

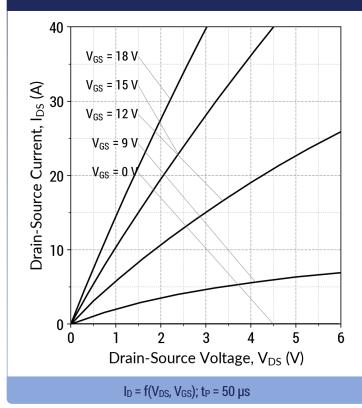
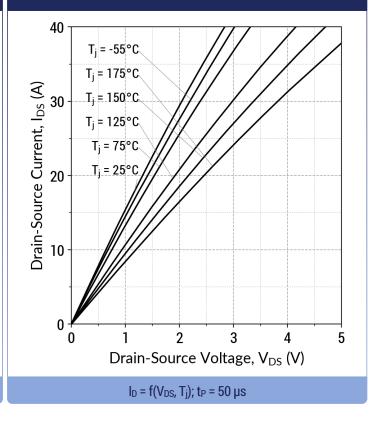


Fig 4: Typical Output Characteristics (V_{GS} = 18 V)



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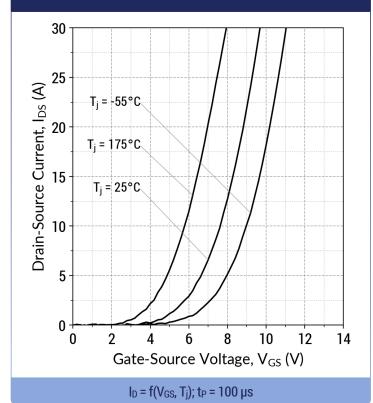
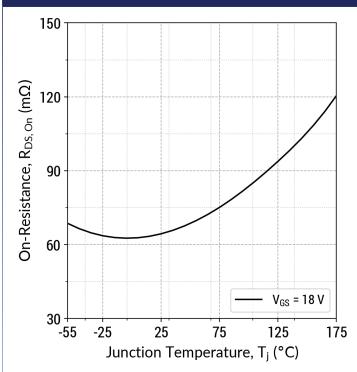


Fig 6: Typical R_{DS(ON)} v/s Temperature



 $R_{DS(ON)} = f(T_j, V_{GS}); t_P = 50 \mu s; I_D = 13 A$

Fig 7: Typical RDS(ON) v/s Drain Current

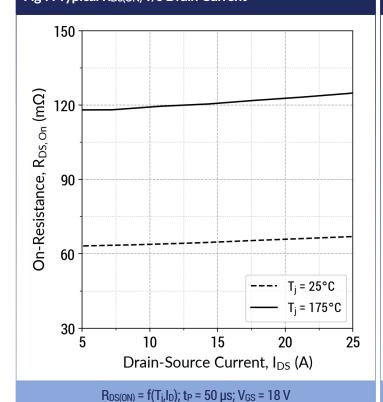
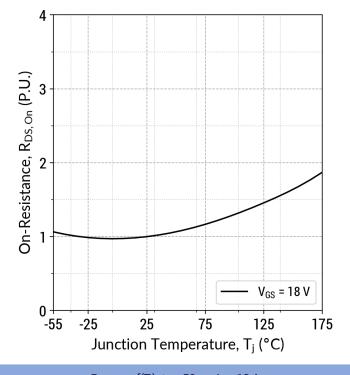


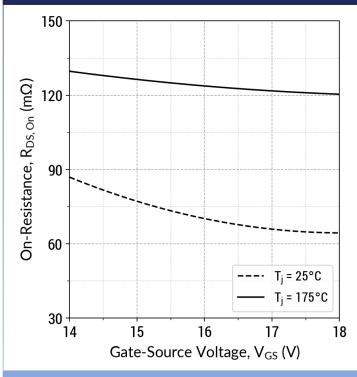
Fig 8: Typical Normalized RDS(ON) v/s Temperature



 $R_{DS(ON)} = f(T_j); t_P = 50 \mu s; I_D = 13 A$

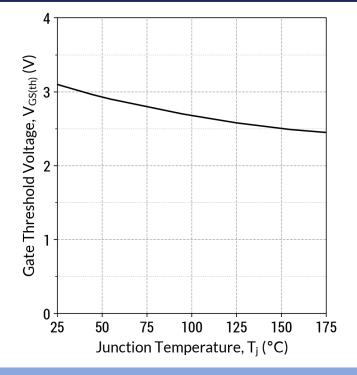
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 $R_{DS(ON)} = f(T_i, V_{GS}); t_P = 50 \mu s; I_D = 13 A$

Fig 10: Typical Threshold Voltage Characteristics



 $V_{GS(th)} = f(T_j)$; $V_{DS} = V_{GS}$; $I_D = 10 \text{ mA}$

Fig 11: Typical Gate Charge Characteristics

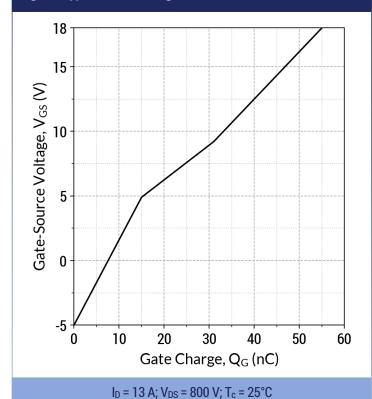
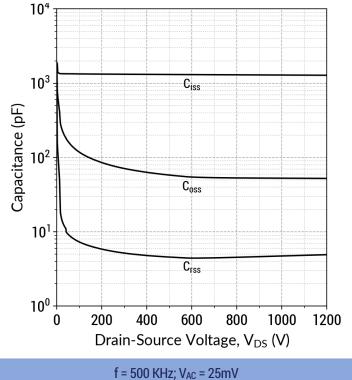
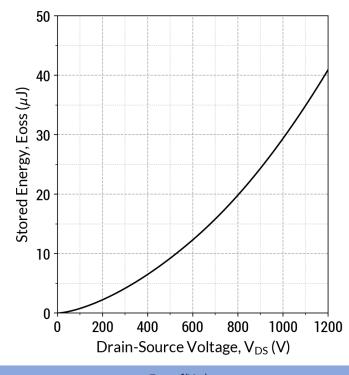


Fig 12: Typical Capacitance v/s Drain-Source Voltage



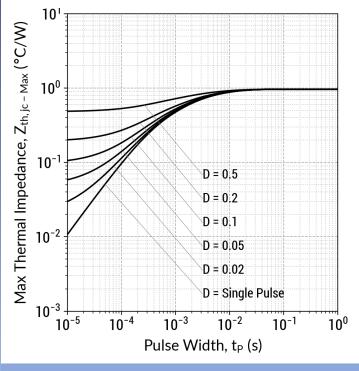
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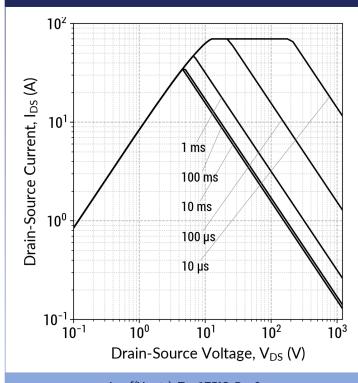
 $E_{oss} = f(V_{DS})$

Fig 14: Max. Transient Thermal Impedance



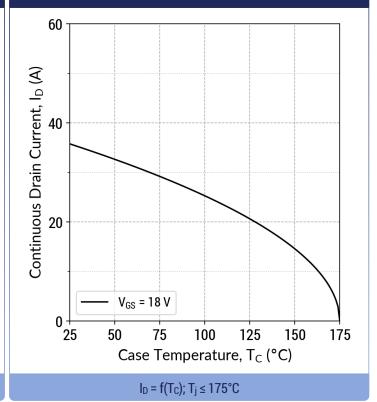
 $Z_{th,ic} = f(t_P,D); D = t_P/T$

Fig 15: Safe Operating Area ($T_c = 25^{\circ}C$)



 $I_D = f(V_{DS}, t_P); T_i \le 175^{\circ}C; D = 0$

Fig 16: Current De-rating Curve



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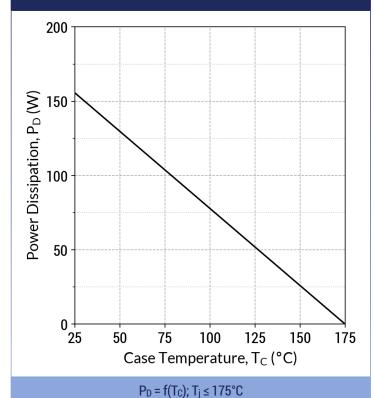


Fig 18: Typical Body Diode Characteristics ($T_j = 25$ °C)

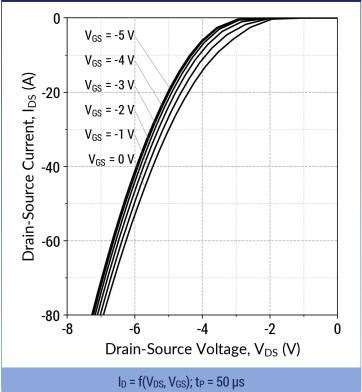


Fig 19: Typical Body Diode Characteristics ($T_j = 175$ °C)

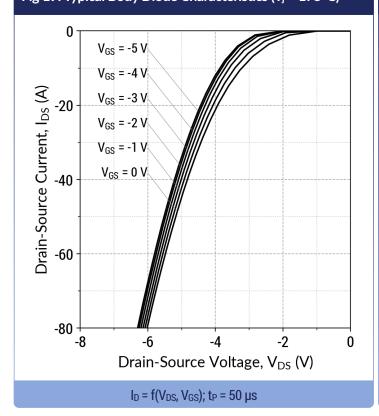
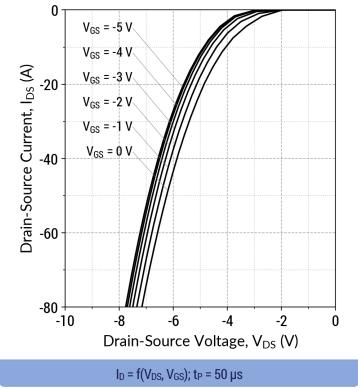


Fig 20: Typical Body Diode Characteristics ($T_j = -55$ °C)



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Fig 21: Typical Third Quadrant Characteristics ($T_j = 25$ °C)

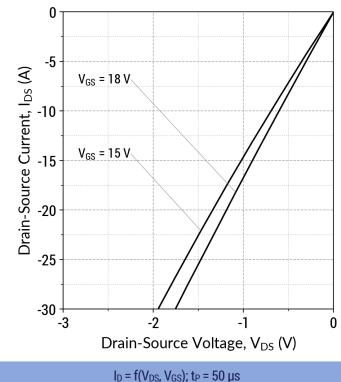
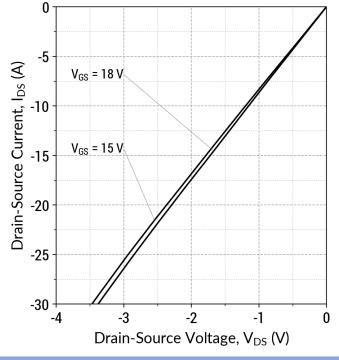


Fig 22: Typical Third Quadrant Characteristics ($T_j = 175^{\circ}$ C)



 $I_D = f(V_{DS}, V_{GS}); t_P = 50 \mu s$

Fig 23: Typical Third Quadrant Characteristics (T_j = -55°C)

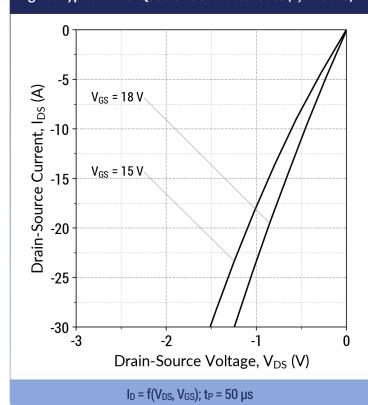
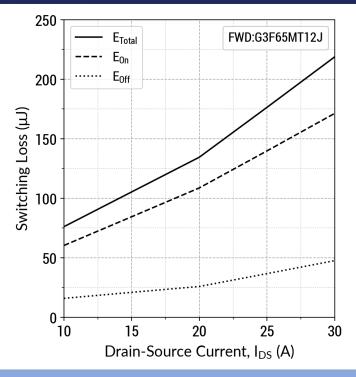


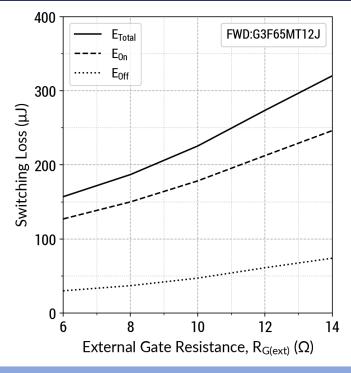
Fig 24: Inductive Switching Energy v/s Drain Current $(V_{DD} = 600V)$



 $T_i = 25$ °C; $V_{GS} = -5/+18V$; $R_{G(ext)} = 8 \Omega$; $L = 80.0 \mu H$

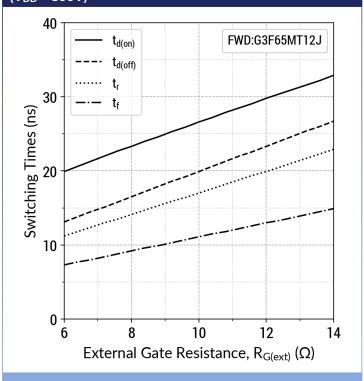
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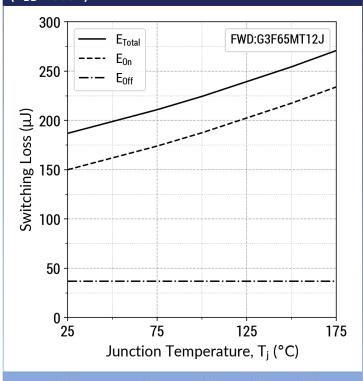
 $T_i = 25$ °C; $V_{GS} = -5/+18V$; $I_{DS} = 20$ A; $L = 80.0 \mu H$

Fig 26: Switching Time v/s R_{G(ext)} (V_{DD} = 800V)



 $T_i = 25$ °C; $V_{GS} = -5/+18V$; $I_{DS} = 20$ A; $L = 80.0 \mu H$

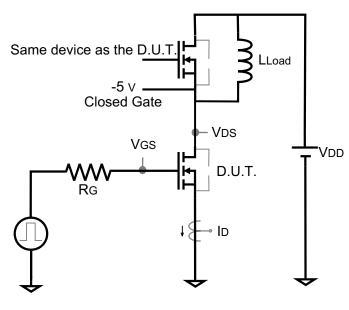
Fig 27: Inductive Switching Energy v/s Temperature $(V_{DD} = 800V)$



 T_j = 25°C; V_{GS} = -5/+18V; $R_{G(ext)}$ = 8 Ω ; I_{DS} = 20 A; L = 80.0 μ H

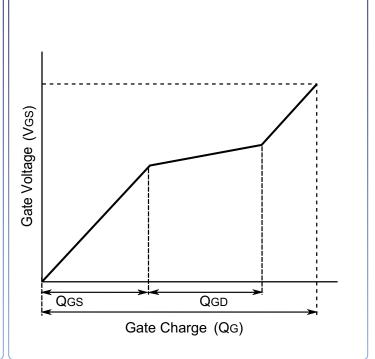
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Dynamic Test Circuit

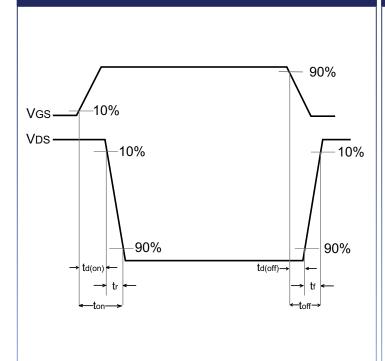


Note: Gate Charge, Switching Time and Energy Circuit

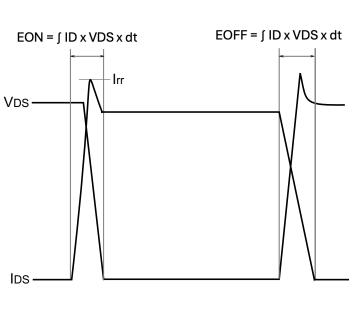
Gate Charge Waveform



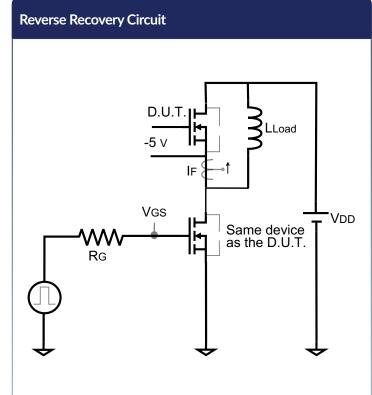
Switching Time Waveform

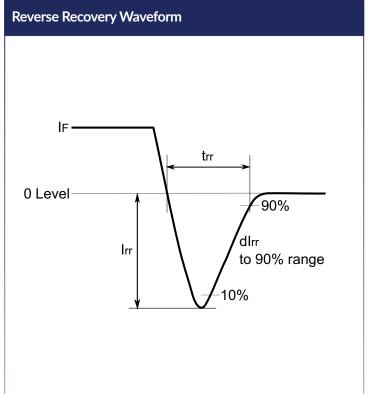


Switching Energy Waveform



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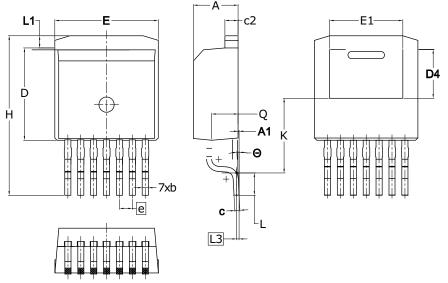
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Package Dimensions

TO-263-7 Package Outline



- All Dimensions Are In mm.
 Dimension D & E Do Not Include Mold Flash.
 These Dimensions Are Measured At The Outermost
- Extreme Of The Plastic Body.

 3. Thermal Pad Contour Optional Within Dimensions E, L1, D4 & E1.

 4. Dimension D4 & E1 Establish A Minmum Mounting Surface for
- The Thermal Pad.

 5. is Exposed Cu.
- 6. There is Exposed Cu and Molding Flash Bleeding At The Pin Which is Close To Package.

SYMBOL	DIMENSIONS				
STMBOL	MIN.	MAX.			
Α	4.30	4.50			
A1	0.00	0.25			
b	0.50	0.70			
С	0.45 0.				
c2	1.20 1.4				
D	8.93 9.3				
D4	4.65 4.				
Е	10.08 10				
E1	6.82 7.6				
е	1.27 BSC				
Н	15.00 16				
К	7.30				
L	1.90 2.5				
L1	1.00 1.40				
L3	0.25 BSC				
Q	2.45 2.75				
Θ	0° 7°				

NOTE

- 1. CONTROLLED DIMENSION IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.
- 3. THE SOURCE AND KELVIN-SOURCE PINS ARE NOT INTERCHANGABLE. THEIR EXCHANGE MIGHT LEAD TO MALFUNCTION.

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Revision History

Rev 24/Jul: Initial Release (Rev 1.0)

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